

<IGBT Modules>

CM225DX-34T/CM225DXP-34T

HIGH POWER SWITCHING USE INSULATED TYPE

		Collector current Ic 225A
	LA CO	Collector-emitter voltage V _{CES} 1700V
		Maximum junction temperature T _{vjmax} 1 7 5 °C
DX		●Flat base type
		 Copper base plate (Nickel-plating)
		 RoHS Directive compliant
		●Tin-plating pin terminals
		Collector current Ic 225 A
		Collector-emitter voltage V _{CES} 1 7 0 0 V
	9	Maximum junction temperature T _{vjmax} 1 7 5 °C
DXP		●Flat base type
		 Copper base plate (Nickel-plating)
	Co data diama	 RoHS Directive compliant
		 Tin-plating pressfit terminals
	dual switch (half-bridge)	●UL Recognized under UL1557, File No. E323585

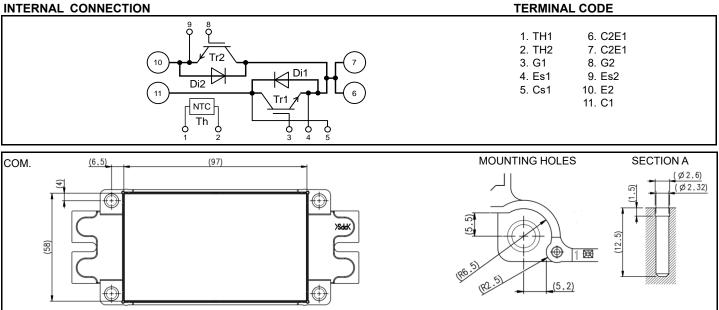
APPLICATION

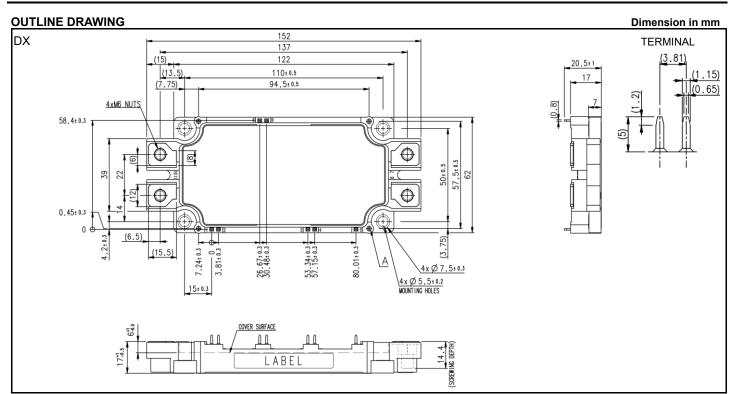
AC Motor Control, Motion/Servo Control, Power supply, etc.

OPTION (Below options are available.)

- •PC-TIM (Phase Change Thermal Interface Material) pre-apply
- •V_{CEsat} selection for parallel connection

INTERNAL CONNECTION

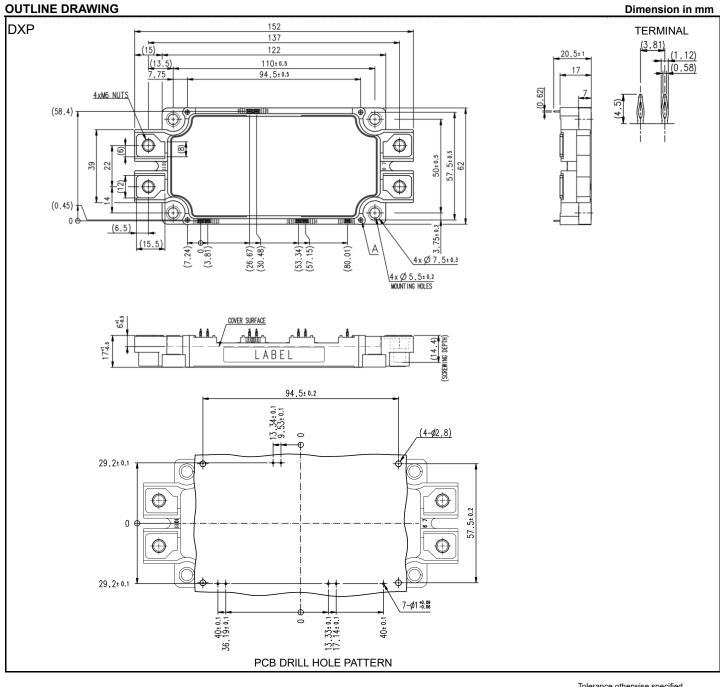




Tolerance otherwise specified

Divisio	on of	Tolerance		
0.5		to	3	±0.2
over	3	to	6	±0.3
over	6	to	30	±0.5
over	30	to	120	±0.8
over 120		to 400		±1.2





Toterance otherwise specified						
Division	n of l	Dime	nsion	Tolerance		
Ū	0.5	to	3	±0.2		
over	3	to	6	±0.3		
over	6	to	30	±0.5		
over	30	to '	120	±0.8		
over 1	20	to 4	100	±1.2		

MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified) INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Rating	Unit	
V _{CES}	Collector-emitter voltage	G-E short-circuited	1700	V	
V _{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V	
lc		DC, T _C =104 °C (Note2, 4)	225	•	
ICRM	Collector current	Pulse, Repetitive (Note3)	450	A	
Ptot	Total power dissipation	T _C =25 °C (Note2, 4)	1440	W	
IE (Note1)		DC (Note2)	225	•	
IERM (Note1)	Emitter current	Pulse, Repetitive (Note3)	450	- A	

MODULE

Symbol	Item	Conditions	Rating	Unit
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min		V
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload) (Note9)	175	ŝ
T _{Cmax}	Maximum case temperature	(Note4, 9)	125	
Tvjop	Operating junction temperature	Continuous operation (under switching) (Note9)	-40 ~ +150	ŝ
Tstg	Storage temperature	-	-40 ~ +125	

ELECTRICAL CHARACTERISTICS (T_{vj} =25 °C, unless otherwise specified) INVERTER PART IGBT/FWD

Currench e l	vmbol Item Conditio				Limits		
Symbol	item	Conditions		Min.	Тур.	Max.	Unit
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1.0	mA
IGES	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	0.5	μA
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I _C =22.5 mA, V _{CE} =10 V		5.4	6.0	6.6	V
		I _C =225 A, V _{GE} =15 V,	T _{vj} =25 °C	-	2.00	2.40	
V _{CEsat} (Terminal)		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.40	-	V
(Terminal)		(Note5)	T _{vj} =150 °C	-	2.50	-	1
	Collector-emitter saturation voltage	I _C =225 A,	T _{vj} =25 °C	-	1.95	2.35	
V _{CEsat}		V _{GE} =15 V,	T _{vj} =125 °C	-	2.35	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.45	-	1
Cies	Input capacitance			-	-	60	
Coes	Output capacitance	V _{CE} =10 V, G-E short-circuited		-	-	1.6	nF
Cres	Reverse transfer capacitance				-	0.5	1
Q _G	Gate charge	V _{cc} =1000 V, I _c =225 A, V _{GE} =15 V			1.76	-	μC
t _{d(on)}	Turn-on delay time	V _{cc} =1000 V, I _c =225 A, V _{GE} =±15 V,		-	-	800	- ns
tr	Rise time			-	-	200	
$t_{d(off)}$	Turn-off delay time			-	-	800	
t _f	Fall time	$-R_{\rm G}=0$ Ω, Inductive load		-	-	600	1
		I _E =225 A, G-E short-circuited,	T _{vj} =25 °C	-	2.70	3.30	
V _{EC} (Note1)		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.90	-	V
(Terminal)		(Note5)	T _{vj} =150 °C	-	2.90	-	1
• • (Ni=t=1)	Emitter-collector voltage	I _E =225 A,	T _{vj} =25 °C	-	2.65	3.25	
V _{EC} (Note1)		G-E short-circuited,	T _{vj} =125 °C	-	2.75	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.75	-	1
t _{rr} (Note1)	Reverse recovery time	V _{CC} =1000 V, I _E =225 A, V _{GE} =±15 V,			-	300	ns
Qrr (Note1)	Reverse recovery charge	$R_{G}=0 \Omega$, Inductive load		-	10.2	-	μC
Eon	Turn-on switching energy per pulse	V _{cc} =1000 V, I _c =I _E =225 A,		-	51.5	-	
E _{off}	Turn-off switching energy per pulse	V _{GE} =±15 V, R _G =0 Ω, T _{vi} =150 °C,		-	56.4	-	mJ
Err (Note1)	Reverse recovery energy per pulse	Inductive load		-	29.0	-	mJ
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, per switch, T _C =25 °C	(Note4)	-	0.94	-	mΩ
r _g	Internal gate resistance	Per switch		-	3.3	-	Ω

ELECTRICAL CHARACTERISTICS (cont.; T_{vj} =25 °C, unless otherwise specified) NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
		Conditions		Тур.	Max.	Unit
R ₂₅	Zero-power resistance T _c =25 °C (Note4)		4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R ₁₀₀ =493 Ω, T _C =100 °C ^(Note4)	-7.3	-	+7.8	%
B _(25/50)	B-constant	Approximate by equation (Note6)	-	3375	-	К
P ₂₅	Power dissipation	T _C =25 °C (Note4)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	ltom	Conditions	Limits			Unit
	Item	Conditions		Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	104	K/kW
R _{th(j-c)D}		Junction to case, per Inverter FWD (Note4)	-	-	176	r./kvv
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, per 1 module, Thermal grease applied ^(Note4, 7, 9)	-	11.5	-	K/kW

MECHANICAL CHARACTERISTICS

Symbol	ltem	Conditions			Unit		
Symbol	Item	0	Conditions		Тур.	Max.	Unit
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N∙m
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m
		Caldennin tura (DV)	Terminal to terminal	17	-	-	
-	Creepage distance	Solder pin type (DX)	Terminal to base plate	18.1	-	-	mm
ds		Pressfit pin type (DXP)	Terminal to terminal	17	-	-	mm
			Terminal to base plate	18.6	-	-	
		Solder pin type (DX)	Terminal to terminal	10	-	-	mm
			Terminal to base plate	16.2	-	-	
da	Clearance		Terminal to terminal	10	-	-	
		Pressfit pin type (DXP) Terminal to base plate		16.2	-	-	mm
ec	Flatness of base plate	On the centerline X, Y (Note8)		±0	-	+200	μm
m	mass	-	-	300	-	g	

*. This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU) 2015/863.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

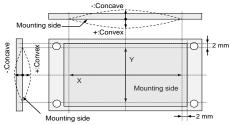
- 2. Junction temperature (T $_{\nu j}$) should not increase beyond T $_{\nu j\,m\,a\,x}$ rating.
- 3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.
- 4. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6.
$$B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$$

 $R_{25}\!\!:$ resistance at absolute temperature T_{25} [K]; $T_{25}\!\!=\!\!25$ [°C]+273.15=298.15 [K]

- R_{50} : resistance at absolute temperature T_{50} [K]; $T_{50}\text{=}50$ [°C]+273.15=323.15 [K]
- 7. Reference value. Thermally conductive grease of thermal conductivity λ =0.9 W/(m·K) and thickness D_(C-S)=50 µm.
- 8. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



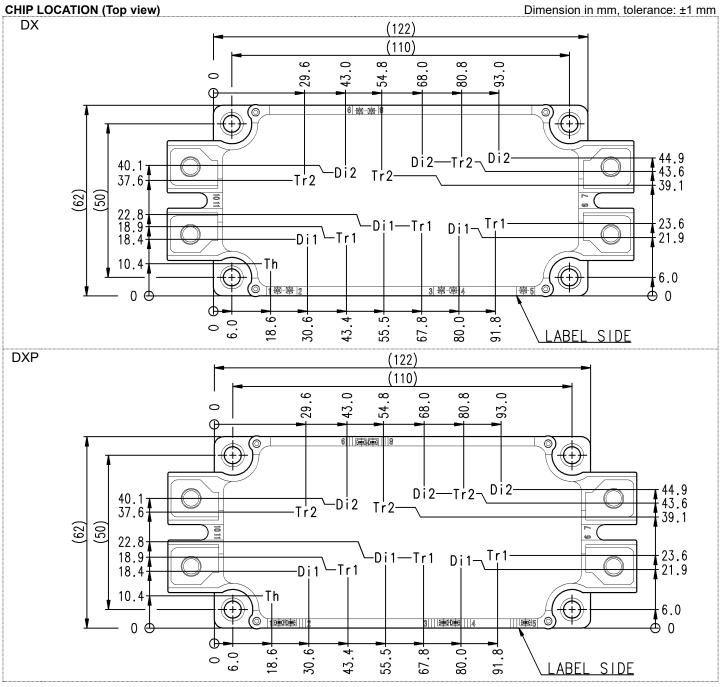
9. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under user's specific application conditions. Each temperature condition (T_{vj max}, T_{vj op}, T_{C max}) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

Note10. Use the following screws when mounting the printed circuit board (PCB) on the standoffs. PCB thickness : t1.6

		Туре	Manufacturer	Size	Tightening torque (N•m)	Recommended tightening method
((1)	PT®	EJOT	K25×8	0.55 ± 0.055	
(2)	PT®		K25×10	0.75 ± 0.075 N∙m	by handwork (equivalent to 30 rpm
((3)	DELTA PT®		25×8	0.55 ± 0.055 N∙m	by mechanical screw driver)
((4)	DELTA PT®		25×10	0.75 ± 0.075 N∙m	~ 600 rpm (by mechanical screw driver)
((5)	B1	-	φ2.6×10	0.75 ± 0.075 N ⋅ m	
		tapping screw		φ2.6×12	0.75 ± 0.075 N•III	

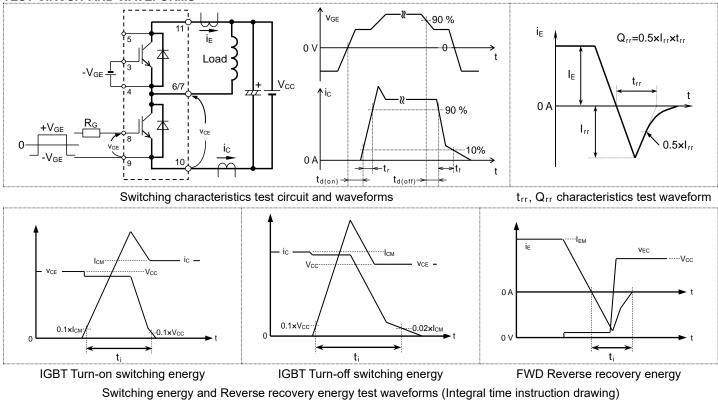
RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions		Unit		
	nem	Conditions	Min.	Тур.	Max.	Unit
V _{cc}	(DC) Supply voltage	Applied across C1-E2 terminals		1000	1200	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G1-Es1/G2-Es2 terminals	13.5	15.0	16.5	V
R _G	External gate resistance	Per switch	0	-	30	Ω

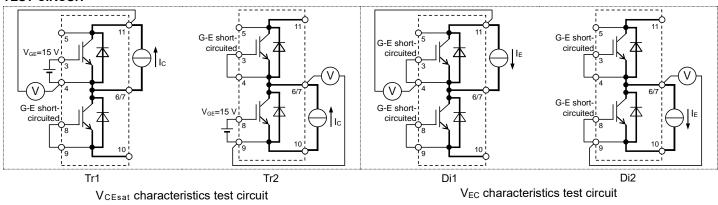


Tr1/Tr2: IGBT, Di1/Di2: FWD, Th: NTC thermistor



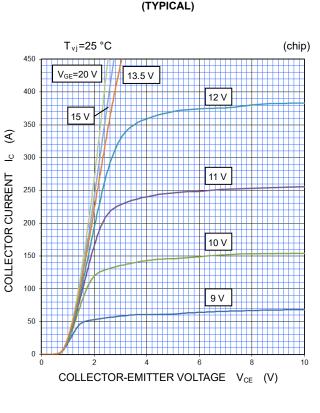


TEST CIRCUIT



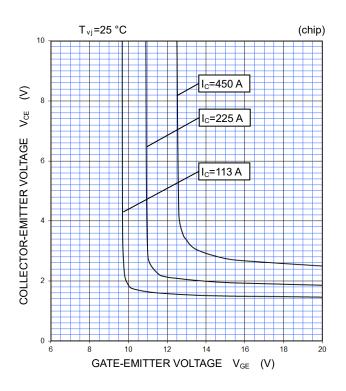
PERFORMANCE CURVES

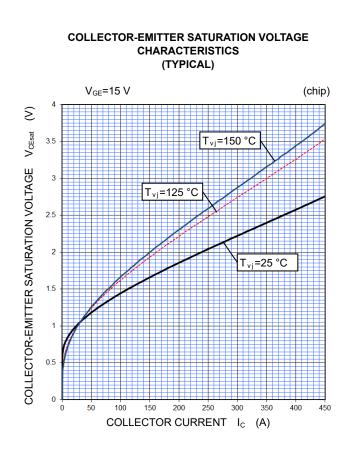
INVERTER PART



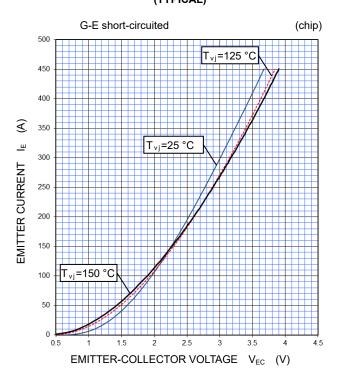
OUTPUT CHARACTERISTICS

COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)





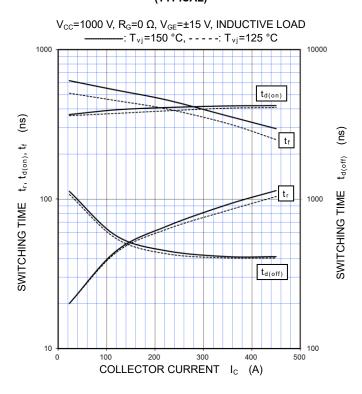
FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



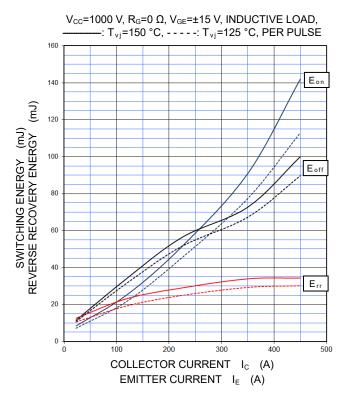
PERFORMANCE CURVES

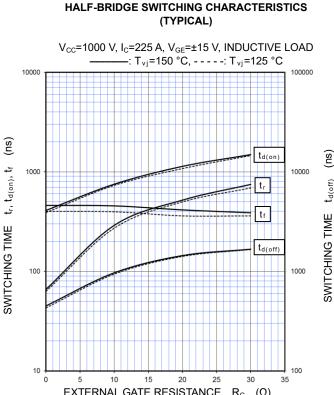
INVERTER PART

HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

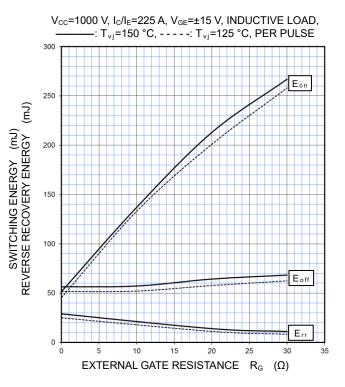


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)





HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



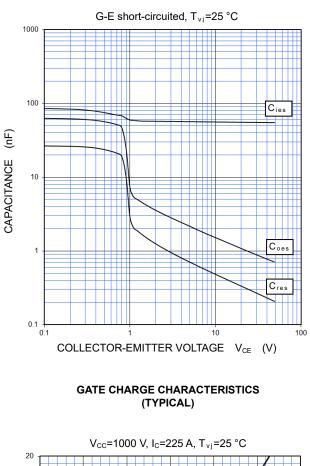
EXTERNAL GATE RESISTANCE R_{G} (Ω)

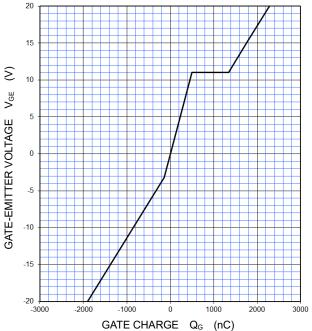
Publication Date : January 2025

PERFORMANCE CURVES

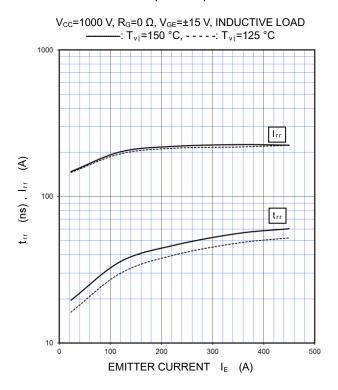
INVERTER PART

CAPACITANCE CHARACTERISTICS (TYPICAL)

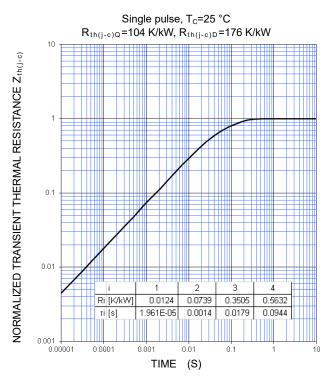




FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



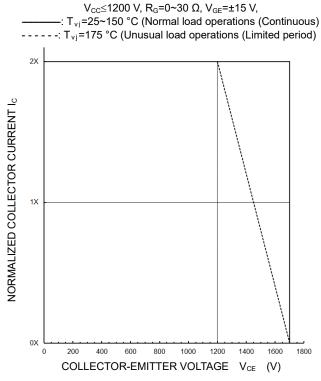
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



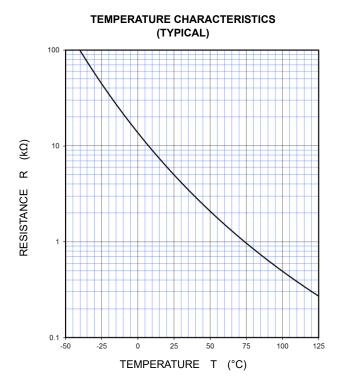
PERFORMANCE CURVES

INVERTER PART

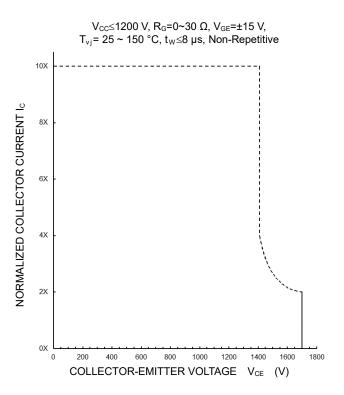
TURN-OFF SWITCHING SAFE OPERATIONG AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)



NTC thermistor part







Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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